

<b>Notice of References Cited</b>	Application/Control No. 10/537,120		Applicant(s)/Patent Under Reexamination KOYAMA ET AL.	
	Examiner Michael Bernshteyn		Art Unit 1713	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,015,363	03-2006	Shimizu et al.	568/591
*	B	US-5,994,025	11-1999	Iwasa et al.	430/270.1
*	C	US-2002/0177068	11-2002	Park et al.	430/270.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 2003006407 A1	01-2003	World Intellect	ITO et al.	
*	O	JP 2000187327 A	07-2000	Japan	SATO, KENICHIRO	
*	P	JP 2001188346 A	07-2001	Japan	DOUKI et al.	
*	Q	JP 2001240625 A	09-2001	Japan	GOKOCHI et al.	
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.